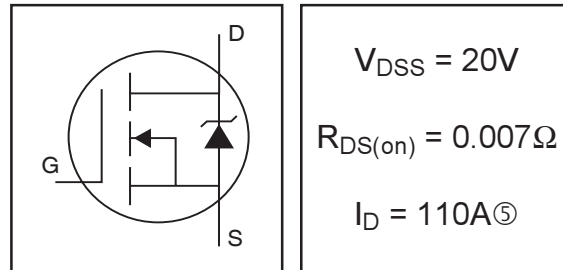


# IRL3502PbF

HEXFET® Power MOSFET

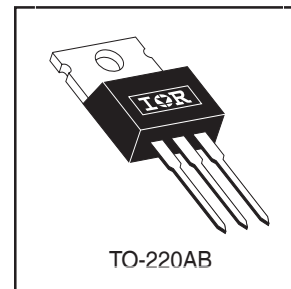
- Advanced Process Technology
- Optimized for 4.5V-7.0V Gate Drive
- Ideal for CPU Core DC-DC Converters
- Fast Switching
- Lead-Free



## Description

These HEXFET Power MOSFETs were designed specifically to meet the demands of CPU core DC-DC converters in the PC environment. Advanced processing techniques combined with an optimized gate oxide design results in a die sized specifically to offer maximum efficiency at minimum cost.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



## Absolute Maximum Ratings

|                                 | Parameter   | Max.               | Units |
|---------------------------------|---|--------------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 5.0\text{V}$                        | 110Ⓢ               | A     |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 5.0\text{V}$                        | 67                 |       |
| $I_{DM}$                        | Pulsed Drain Current ①  | 420                |       |
| $P_D @ T_C = 25^\circ\text{C}$  | Power Dissipation   | 140                | W     |
|                                 | Linear Derating Factor  | 1.1                | W/°C  |
| $V_{GS}$                        | Gate-to-Source Voltage  | $\pm 10$           | V     |
| $V_{GSM}$                       | Gate-to-Source Voltage<br>(Start Up Transient, $t_p = 100\mu\text{s}$ ) | 14                 | V     |
| $E_{AS}$                        | Single Pulse Avalanche Energy②  | 390                | mJ    |
| $I_{AR}$                        | Avalanche Current①  | 64                 | A     |
| $E_{AR}$                        | Repetitive Avalanche Energy①  | 14                 | mJ    |
| $dv/dt$                         | Peak Diode Recovery $dv/dt$ ③   | 5.0                | V/ns  |
| $T_J$                           | Operating Junction and  | -55 to + 150       | °C    |
| $T_{STG}$                       | Storage Temperature Range   |                    |       |
|                                 | Soldering Temperature, for 10 seconds                                   |                    |       |
|                                 | Mounting torque, 6-32 or M3 screw                                       | 10 lbf•in (1.1N•m) |       |

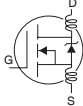
## Thermal Resistance

|                 | Parameter                           | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                    | ---  | 0.89 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | 0.50 | ---  |       |
| $R_{\theta JA}$ | Junction-to-Ambient                 | ---  | 62   |       |

# IRL3502PbF

International  
**IR** Rectifier

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

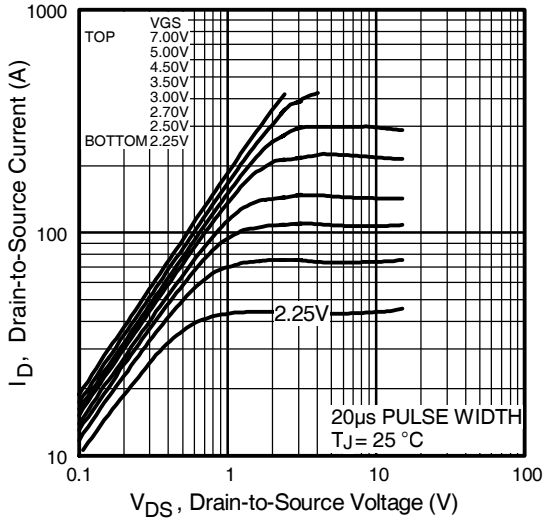
|  | Parameter                            | Min. | Typ.  | Max.  | Units | Conditions   |
|--|--------------------------------------|------|-------|-------|-------|--|
| V <sub>(BR)DSS</sub>                   | Drain-to-Source Breakdown Voltage    | 20   | —     | —     | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA   |
| ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub> | Breakdown Voltage Temp. Coefficient  | —    | 0.019 | —     | V/°C  | Reference to 25°C, I <sub>D</sub> = 1mA  |
| R <sub>DS(on)</sub>                    | Static Drain-to-Source On-Resistance | —    | —     | 0.008 | Ω     | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 64A ④                                       |
|  |                                      | —    | —     | 0.007 |       | V <sub>GS</sub> = 7.0V, I <sub>D</sub> = 64A ④                                       |
| V <sub>GS(th)</sub>                    | Gate Threshold Voltage               | 0.70 | —     | —     | V     | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA                           |
| g <sub>fs</sub>                        | Forward Transconductance             | 77   | —     | —     | S     | V <sub>DS</sub> = 10V, I <sub>D</sub> = 64A  |
| I <sub>DSS</sub>                       | Drain-to-Source Leakage Current      | —    | —     | 25    | μA    | V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V  |
|  |                                      | —    | —     | 250   |       | V <sub>DS</sub> = 10V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 150°C                  |
| I <sub>GSS</sub>                       | Gate-to-Source Forward Leakage       | —    | —     | 100   | nA    | V <sub>GS</sub> = -10V   |
|  | Gate-to-Source Reverse Leakage       | —    | —     | -100  |       | V <sub>GS</sub> = 10V  |
| Q <sub>g</sub>                         | Total Gate Charge                    | —    | —     | 110   | nC    | I <sub>D</sub> = 64A   |
| Q <sub>gs</sub>                        | Gate-to-Source Charge                | —    | —     | 27    |       | V <sub>DS</sub> = 16V  |
| Q <sub>gd</sub>                        | Gate-to-Drain ("Miller") Charge      | —    | —     | 39    |       | V <sub>GS</sub> = 4.5V, See Fig. 6 ④   |
| t <sub>d(on)</sub>                     | Turn-On Delay Time                   | —    | 10    | —     | ns    | V <sub>DD</sub> = 10V  |
| t <sub>r</sub>                         | Rise Time                            | —    | 140   | —     |       | I <sub>D</sub> = 64A   |
| t <sub>d(off)</sub>                    | Turn-Off Delay Time                  | —    | 96    | —     |       | R <sub>G</sub> = 3.8Ω, V <sub>GS</sub> = 4.5V  |
| t <sub>f</sub>                         | Fall Time                            | —    | 130   | —     |       | R <sub>D</sub> = 0.15Ω, ④  |
| L <sub>D</sub>                         | Internal Drain Inductance            | —    | 4.5   | —     | nH    | Between lead,<br>6mm (0.25in.)<br>from package<br>and center of die contact          |
| L <sub>S</sub>                         | Internal Source Inductance           | —    | 7.5   | —     |       |  |
| C <sub>iss</sub>                       | Input Capacitance                    | —    | 4700  | —     | pF    | V <sub>GS</sub> = 0V   |
| C <sub>oss</sub>                       | Output Capacitance                   | —    | 1900  | —     |       | V <sub>DS</sub> = 15V  |
| C <sub>rss</sub>                       | Reverse Transfer Capacitance         | —    | 640   | —     |       | f = 1.0MHz, See Fig. 5   |

## Source-Drain Ratings and Characteristics

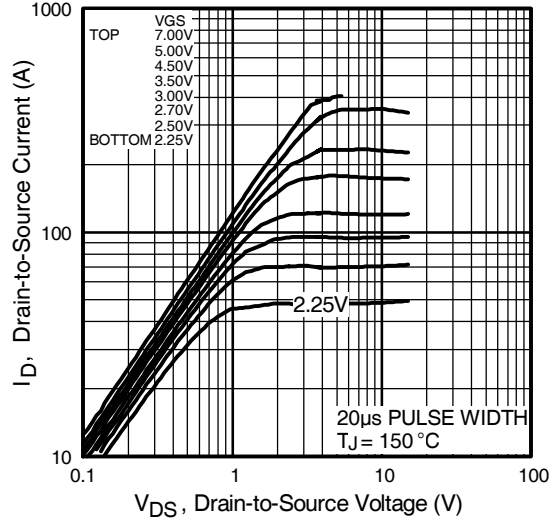
|                 | Parameter                                 | Min.   | Typ. | Max.             | Units | Conditions  |
|-----------------|---|--|------|------------------|-------|---|
| I <sub>S</sub>  | Continuous Source Current<br>(Body Diode) | —  | —    | 110 <sup>⑤</sup> | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| I <sub>SM</sub> | Pulsed Source Current<br>(Body Diode) ①   | —  | —    | 420              |       |   |
| V <sub>SD</sub> | Diode Forward Voltage                     | —  | —    | 1.3              | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 64A, V <sub>GS</sub> = 0V ④     |
| t <sub>rr</sub> | Reverse Recovery Time                     | —  | 87   | 130              | ns    | T <sub>J</sub> = 25°C, I <sub>F</sub> = 64A                             |
| Q <sub>rr</sub> | Reverse Recovery Charge                   | —  | 200  | 310              | nC    | di/dt = 100A/μs ④   |
| t <sub>on</sub> | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> ) |      |                  |       |   |

### Notes:

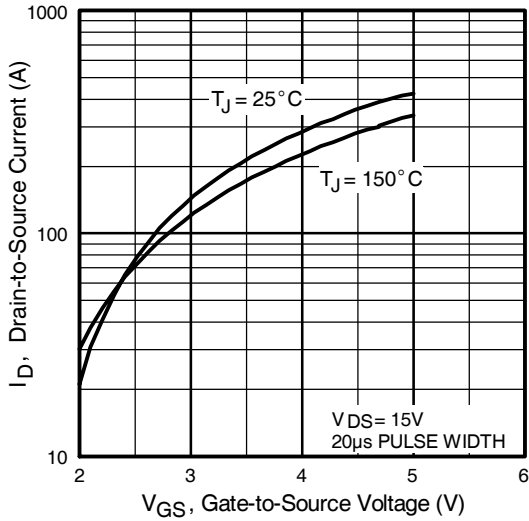
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting T<sub>J</sub> = 25°C, L = 190μH  
R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 64A.
- ③ I<sub>SD</sub> ≤ 64A, di/dt ≤ 86A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>,  
T<sub>J</sub> ≤ 150°C
- ④ Pulse width ≤ 300μs; duty cycle ≤ 2%.
- ⑤ Calculated continuous current based on maximum allowable junction temperature; for recommended current-handling of the package refer to Design Tip # 93-4



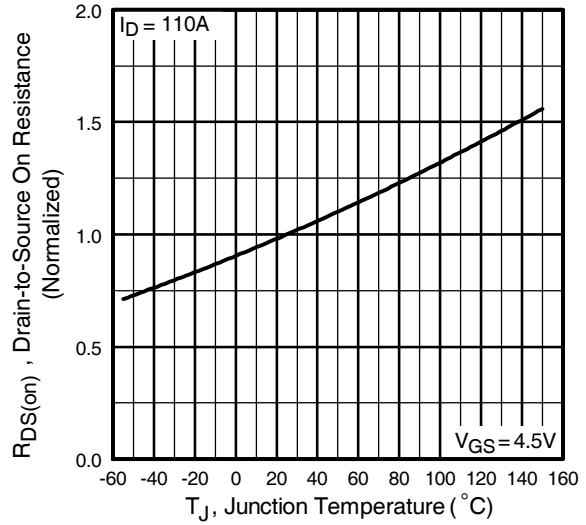
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics

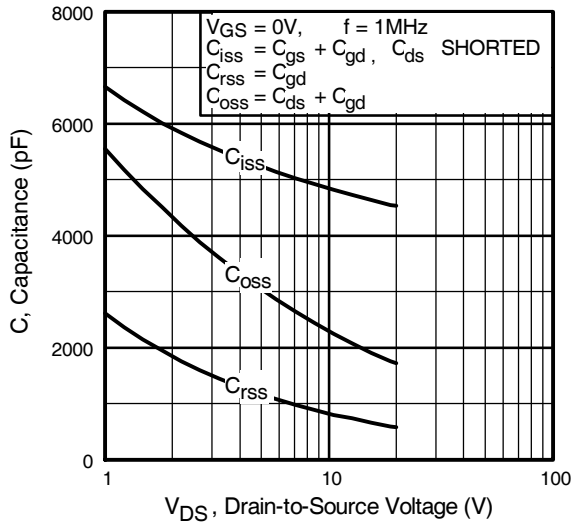


**Fig 3.** Typical Transfer Characteristics

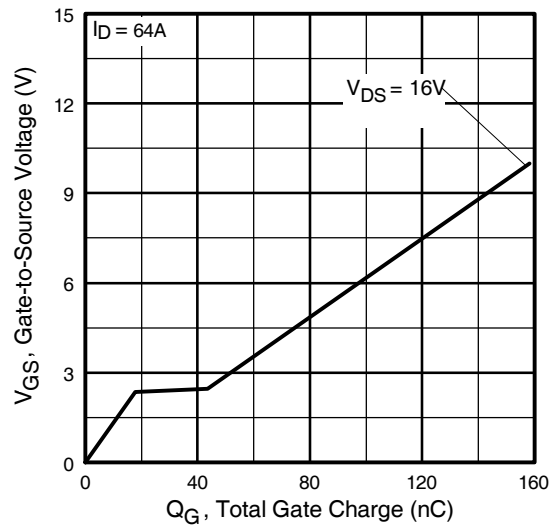


**Fig 4.** Normalized On-Resistance Vs. Temperature

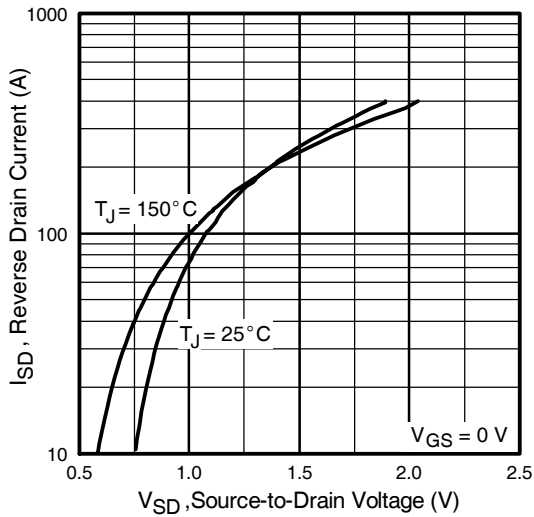
# IRL3502PbF



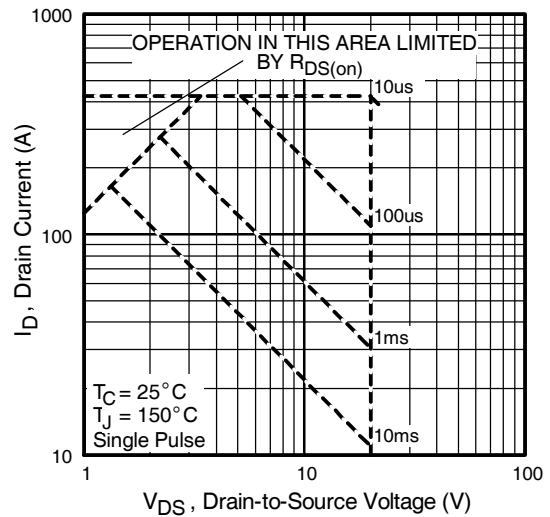
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



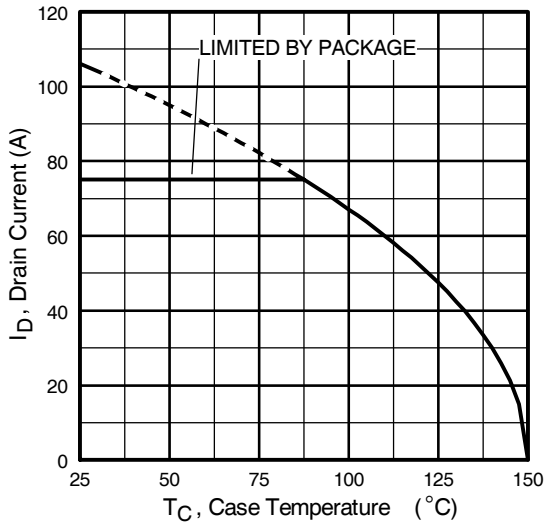
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



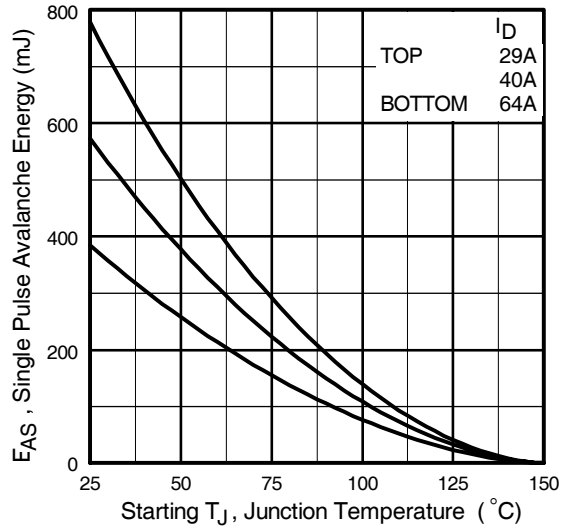
**Fig 7.** Typical Source-Drain Diode Forward Voltage



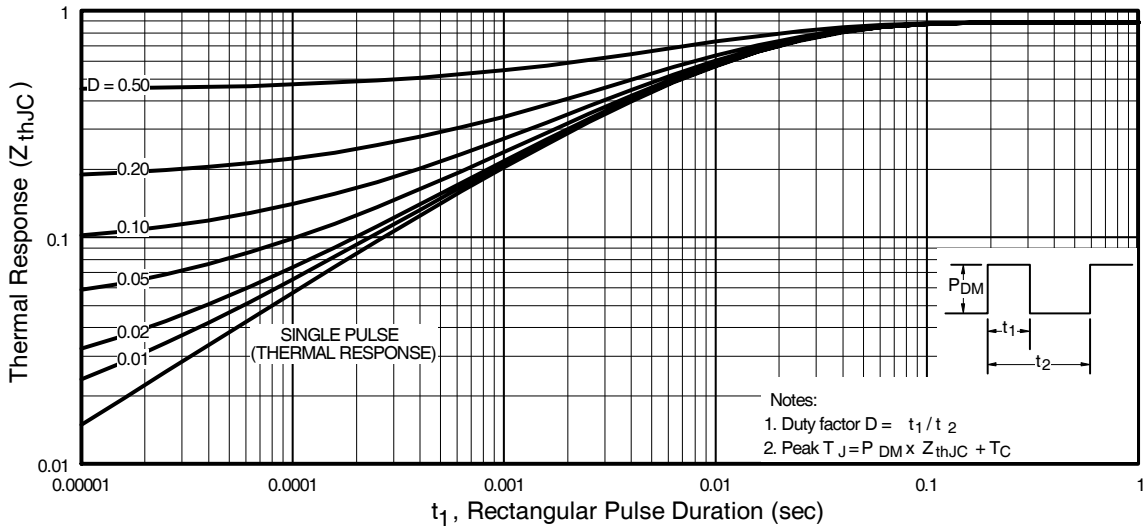
**Fig 8.** Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature



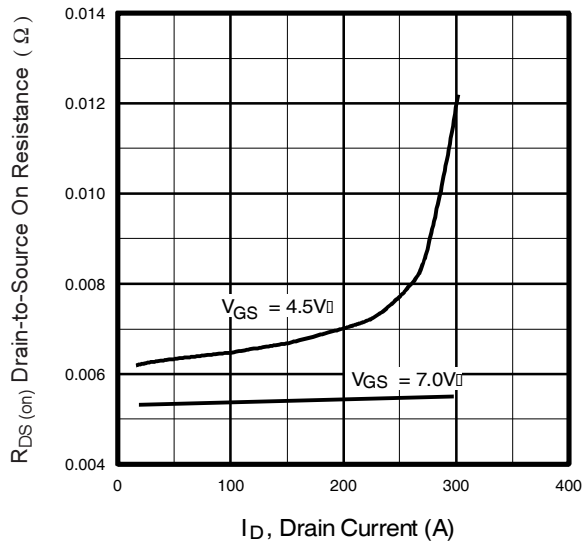
**Fig 10.** Maximum Avalanche Energy Vs. Drain Current



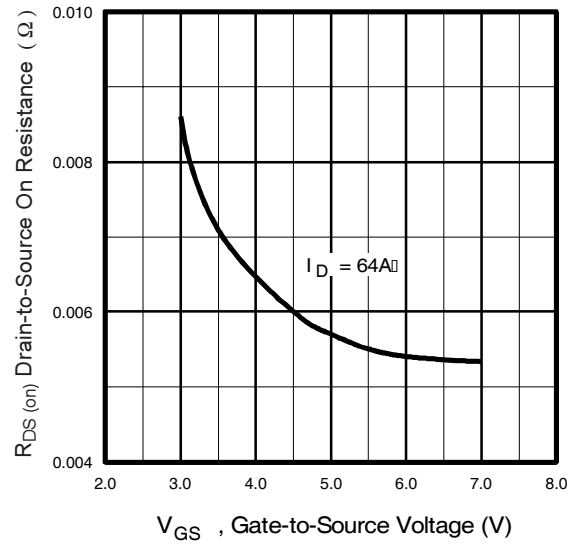
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRL3502PbF

International  
**IR** Rectifier



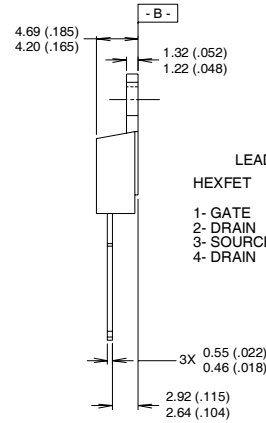
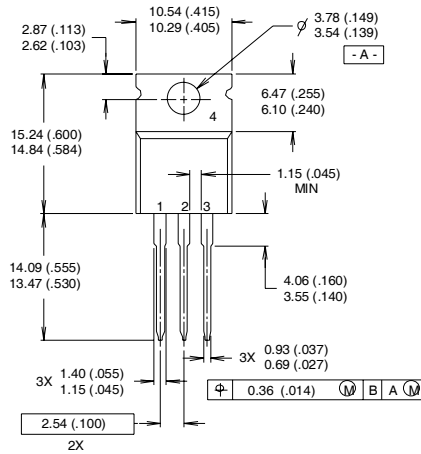
**Fig 12.** On-Resistance Vs. Drain Current



**Fig 13.** On-Resistance Vs. Gate Voltage

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



LEAD ASSIGNMENTS

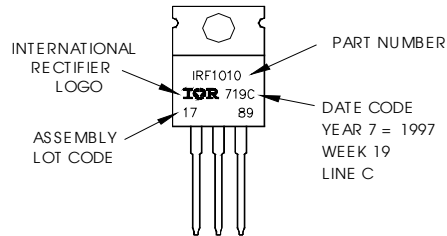
| HEXFET    | IGBTs, CoPACK |
|-----------|---------------|
| 1- GATE   | 1- GATE       |
| 2- DRAIN  | 2- COLLECTOR  |
| 3- SOURCE | 3- EMITTER    |
| 4- DRAIN  | 4- COLLECTOR  |

NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH
- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"  
**Note:** "P" in assembly line  
 position indicates "Lead-Free"



Data and specifications subject to change without notice.

Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>